Supporting information for: One more attempt on ArXe

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Electron-electron coincidence spectra

In this work, we use electron-electron coincidence spectroscopy to isolate electrons from autoionization decays of Ar 3s⁻¹ vacancies from the remainder of the electron spectrum, mostly photoelectrons from outer valence levels and secondary electrons from intracluster inelastic collisions. By recording two electrons ejected in the same process, on an event-by-event basis, we are able to identify those secondary electrons which are ejected after Ar 3s photoionization. Here, we show a more detailed representation of the electron-electron coincidence data, from which figures in the main paper showing the ICD/ETMD spectra, and the pertaining Ar 3s photoelectron spectra, were derived.

A necessary condition for the ejection of two electrons by a single photon, irrespective of the mechanism by which this is accomplished, is a sufficient photon energy. In case of a sequential process, such as photoionization followed by ICD/ETMD, moreover the ionic state which is produced in the primary step must be located above the ionization threshold for the doubly ionized systems. For Ar 3s autoionization, these conditions are discussed in detail in the main paper. For a general double ionization process, the required energy can be estimated as the sum of the single ionization energies of the final state holes (main paper, Table 3) plus the geometry-dependent Coulomb repulsion (main paper, Figure 1). Roughly, 27 eV are needed to produce an Ar $3p^{-1}$ Xe $5p_{3/2}^{-1}$ state, and about 2-4 eV less for (Xe $5p^{-1}$)₂ states. For photon energies exceeding this limit, the excess energy can be distributed to any, or both, of the released electrons. For photoionization followed by autoionization the energy imparted to the first electron is determined by the binding energy of the primary vacancy, however. This can be used to identify the pertaining second-step spectrum.

Figure S1b shows a typical electron-electron coincidence spectrum recorded with a photon energy of 32 eV, a few eV above the inner valence ionization thresholds.

The Figure shows that a significant amount of slow electrons e_2 are recorded in coincidence with the primary 3s electrons (e_1) , which have a kinetic energy of approx. 3.3 eV. Some background of electron pairs at other energies is also visible. It results from inelas-

tic scattering of outer valence photoelectrons, and (in particular for the feature which has both electrons with kinetic energy less than 0.2 eV, upper left corner of Figure S1b) due to inelastic scattering at parts of the analyzer.

More conventional, one-dimensional electron spectra pertaining to the photoelectrons and the ICD/ETMD electrons are obtained by summing up along one of the energy axis of the two-dimensional map, and are shown in (c) and (a). The peak in Figure S1c at a binding energy of 28.7 eV pertains to the Ar 3s photoelectron line. No atomic counterpart of this line is visible in this Figure, as only the cluster photoelectrons lead to electron-electron coincidences. The trace shown in Figure S1a is interpreted as the spectral shape of ICD/ETMD decays.

We have subtracted the background from random coincidences or coincidences due to electron scattering from the signals shown in Figures S1a,c. In order to do so, the regions between the two pairs of red horizontal bars in Figure S1b were identified as background. The coincidence map was then subdivided into intervals of 0.5 eV width in the e_2 energy coordinate. For each interval, a second order polynomial was fitted to the background signal, and subsequently subtracted from the ICD/ETMD signal marked by the black bars. The summation of all background signals is shown as a wavy, solid red line in Figure S1c, and the signal of secondary electrons, background subtracted, is shown as the lower trace of data points in Figure S1a. Background subtracted ICD/ETMD signals are shown throughout the main paper.

These data were recorded under all expansion conditions listed in Table 1. Similar figures were recorded for all combinations of expansion parameters listed in Table 1 of the main paper. A more detailed description of methods for analysing these data sets has been given. S1

References

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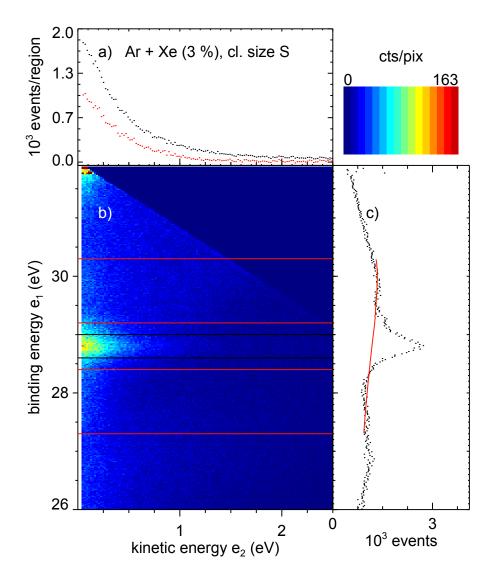


Figure S1: Photon excited electron-electron coincidence spectrum of mixed Ar-Xe clusters in the inner valence region. (b): Color-coded map of coincident electron pairs, with the electron of higher kinetic named e_1 . The energy of e_1 is given as binding energy, using the photon energy of $h\nu = 32$ eV. (c): Energy spectrum of primary electrons e_1 , irrespective of the energy of the secondary electron (summation of the coincidence map along horizontal lines). (a): Energy spectrum of all secondary (ICD or ETMD) electrons e_2 pertaining to the Ar 3s binding energy region marked by two black bars. See text for details. Intensity is expressed as coincident events/pixel of 20 meV² (b) or as coincident events per interval of 20 meV (a,c). In total, approx. 4×10^5 events are shown. The color scale of (b) is linear.